


<b>Search Notes</b> 	<b>Application/Control No.</b> 10667382	<b>Applicant(s)/Patent Under Reexamination</b> ISHII, AKIRA
	<b>Examiner</b> QUANG N VO	<b>Art Unit</b> 2625

SEARCHED			
Class	Subclass	Date	Examiner
358	3.06	3/26/2009	QV
358	1.9	3/26/2009	QV
358	533	3/26/2009	QV
358	3.26	3/26/2009	QV
358	536	3/26/2009	QV
358	534	3/26/2009	QV

SEARCH NOTES		
Search Notes	Date	Examiner
US Pat, US PG Pub, USOCR, EPO, JPO, DERWENT, IBM	3/26/2009	QV
Inventor Name Search, see attachment	3/26/2009	QV

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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